

Schottky Barrier Diodes

These Schottky barrier diodes are designed for high speed switching applications, circuit protection, and voltage clamping. Extremely low forward voltage reduces conduction loss. Miniature surface mount package is excellent for hand held and portable applications where space is limited.

- Extremely Fast Switching Speed
- Low Forward Voltage — 0.35 Volts (Typ) @ $I_F = 10 \text{ mA}$

ORDERING INFORMATION

Device	Package	Shipping
BAT54LT1	SOT-23	3000/Tape & Reel

Preferred: devices are recommended choices for future use and best overall value.

BAT54LT1

30 VOLTS SILICON HOT-CARRIER
DETECTOR AND SWITCHING
DIODES



CASE 318, STYLE 8
SOT-23 (TO-236AB)



DEVICE MARKING

BAT54LT1 = JV3

MAXIMUM RATINGS ($T_J = 125^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Max	Unit
Reverse Voltage	V_R	30	Volts
Forward Power Dissipation @ $T_A = 25^\circ\text{C}$	P_F	200	mW
Derate above 25°C		2.0	$\text{mW}/^\circ\text{C}$
Forward Current(DC)	I_F	200Max	mA
Junction Temperature	T_J	125Max	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55 to +150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Reverse Breakdown Voltage ($I_R = 10 \mu\text{A}$)	$V_{(BR)R}$	30	—	—	Volts
Total Capacitance ($V_R = 1.0 \text{ V}$, $f = 1.0 \text{ MHz}$)	C_T	—	7.6	10	pF
Reverse Leakage ($V_R = 25 \text{ V}$)	I_R	—	0.5	2.0	μA
Forward Voltage ($I_F = 0.1 \text{ mA}$)	V_F	—	0.22	0.24	Vdc
Forward Voltage ($I_F = 30 \text{ mA}$)	V_F	—	0.41	0.5	Vdc
Forward Voltage ($I_F = 100 \text{ mA}$)	V_F	—	0.52	0.8	Vdc
Reverse Recovery Time ($I_F = I_R = 10 \text{ mA}$, $I_{(REC)} = 1.0 \text{ mA}$, Figure 1)	t_{rr}	—	—	5.0	ns
Forward Voltage ($I_F = 1.0 \text{ mA}$)	V_F	—	0.29	0.32	Vdc
Forward Voltage ($I_F = 10 \text{ mA}$)	V_F	—	0.35	0.40	Vdc
Forward Current (DC)	I_F	—	—	200	mA
Repetitive Peak Forward Current	I_{FRM}	—	—	300	mA
Non-Repetitive Peak Forward Current ($t < 1.0 \text{ s}$)	I_{FSM}	—	—	600	mA

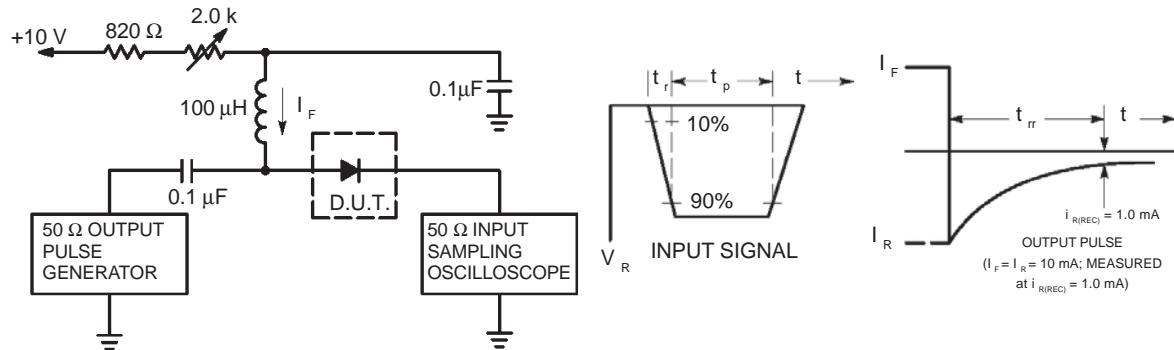
BAT54LT1


Figure 1. Recovery Time Equivalent Test Circuit

